Titanium-based thin films for protective coatings prepared by TVA (Thermionic Vacuum Arc) technology

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Abstract. The aim of the present work is to achieve the controlled synthesis of Ti and Mg thin films, with compact structure and extremely smooth surface, by using the Thermionic Vacuum Arc (TVA) technology, from elemental powder of titanium and magnesium. The thin film exhibits an amorphous structure, with polycrystalline grain mainly being Mg hexagonal phase and small amount of hexagonal Ti. Grain mean size was estimated to be ~120 nm by statistical analysis of measured Feret diameter of projected area of grain. The phases were tested by mean of Cohen method applied to electron diffraction results. No oxide (MgO, TiO2) lines could be identified from electron diffraction. Debye-Scherrer dimension, estimated from electron diffraction profile is ~4 nm. The analysis of amorphous part from diffraction profile show different coordination number for Mg and Ti atoms.

1 Introduction

Advanced materials at the nanometric scale started to be real dimensions for coating the components on production line. [1,3] Specifically, titanium based nanocomposites owing to their remarkable properties of the coating surfaces such as wear resistance, roughness, low friction coefficients have been synthesized and investigated in different combination and forms, such as multi-component composites. [4-7]

Titanium (Ti) is an ideal metal for structural and biomedical applications, having good biocompatibility, mechanical properties and high corrosion resistance. [8-11] By combining Ti and Mg, the resulting Ti–Mg alloys are expected to be useful as metallic biomaterials with good mechanical properties and anticorrosion properties. [12,13]. But, titanium cannot be dissolved in Mg under equilibrium conditions and so we need to use a deposition method that can produce single-phase, non-equilibrium Ti alloys in a wide composition range.

Magnesium is a rather strong, light-weight metal with two-thirds the density of aluminum. Its hygroscopic property- its ability to absorb water - makes it a great drying agent. Magnesium also contributes to an enhanced gripping resistance by its contact surface polishing action. However, because the wear resistance of magnesium products is not nearly as good as steel in ambient and high temperatures, there is a strong request to find a way that can guarantee better wear resistance in the aggressive atmosphere environment [14]. In general, surface treatments are used to improve the surface properties such as wear resistance and corrosion resistance.

When analyzing the mechanical properties of nanostructured metals, one should take into account the peculiar mechanisms of deformation, the role of the grain boundary phase, the mechanisms of grain boundary sliding and diffusional mass transfer. [15] One way to alter the grain size of the material in the controlled way is by using the co-deposition of two materials. Recently, the studies proved that the dependence of the behavior on the particle sizes can allow one to engineer their properties.

The challenge of this work is to find the best combination for coating the mechanical parts of components - especially those exposed to aggressive atmosphere environment - by suitable complex nanocomposites using innovative technology. Multi-component thin films as well as single thin films were deposited using Thermionic Vacuum Arc (TVA) technology. TVA is a versatile deposition method combining anodic arc and electron gun systems for the growth of thin films. [16-18] In this paper we focused on the effects of Mg amount in the the titanium matrix, in terms of microstructural, morphological and mechanical properties.

2 Experimental set-up

The deposition of the Ti-Mg thin films was carried out by using the Thermionic Vacuum Arc (TVA) technology. The principle of TVA method consists in an intense thermal-electron emission from a circular external heated cathode (tungsten filament) focused on the anode (the crucible containing the material to be evaporated) by a Wehnelt cylinder. More details about this method can be find out elsewhere. [19-21] The outstanding features of this coating technique are: the high purity of the deposition, high ion and electron energies, and an
adjustable degree of ionization of the involved species. The experimental set-up is shown in figure 1.

![Figure 1 Schematical diagram of the experimental set-up](image)

The working pressure during the deposition process was about 1.2x10^-5 - 5.5x10^-6 Torr. The evaporation rate was stabilized and controlled with an accuracy of 10%. Thickness measurements were performed in situ using a FTM 7 thickness monitor. The main experimental parameters involved in this study are presented in table 1 where:

- \( I_f \) - the current intensity of the heating filament \( (I_f = 50 \text{ A}) \);
- \( I_a \) - the arc’s current intensity \( (I_a = 165 \cdot 10^{-3} \text{ A}) \);
- \( U_a \) - the applied voltage \( (U_a = 0.74 \cdot 10^3 \text{ V}) \);
- \( t_{dep} \) - the time of deposition \( (t_{dep} = 120 \text{ s}) \);
- \( d_{an-c} \) - the distance between anode and cathode \( (d_{an-c} = 0.005 \text{ m}) \);
- \( d_{as} \) - the distance between samples and the point of the ignition of the discharge \( (d_{as} = 0.16 \text{ m}) \);
- \( \varphi \) - the cathode-anode relative position between a perpendicular line on the crucible centre and the electron gun axis \( (\varphi = 45^\circ) \).

### Table 1. Detailed experimental conditions for the magnesium nanocomposite.

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Value</th>
</tr>
</thead>
<tbody>
<tr>
<td>( I_f ) [A]</td>
<td>50</td>
</tr>
<tr>
<td>( I_a \cdot 10^{-3} ) [A]</td>
<td>165</td>
</tr>
<tr>
<td>( U_a \cdot 10^3 ) [V]</td>
<td>0.74</td>
</tr>
<tr>
<td>( t_{dep} ) [s]</td>
<td>120</td>
</tr>
<tr>
<td>( d_{an-c} ) [m]</td>
<td>0.005</td>
</tr>
<tr>
<td>( d_{as} ) [m]</td>
<td>0.16</td>
</tr>
<tr>
<td>( \varphi ) [^\circ]</td>
<td>45</td>
</tr>
<tr>
<td>Deposition rate [Å/s]</td>
<td>3</td>
</tr>
</tbody>
</table>

### Deposition rate \[Å/s\]

<table>
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<tr>
<th>( d_{an-c} ) [m]</th>
<th>( d_{as} ) [m]</th>
<th>( \varphi ) [^\circ]</th>
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</table>

Three types of substrates were used in this work: silicon wafer, OLC 45 (high-quality carbon steel with 45% C) and glass. Before the deposition, the substrates were chemically cleaned in ultrasonic bath with a highly effective special cleaner and then dried with cold air. The samples were mounted on the support and then inserted into the deposition chamber. After deposition the samples have been kept in the deposition chamber longer time after the power supplies were switch off, under high vacuum, in order to cool down the system temperature.

The samples were characterized using transmission electron microscope (TEM) accompanied with selected area electron diffraction (SAED) and scanning electron microscope (SEM). In addition, the tribological properties were studied by ball-on-disc tribometer made by CSM Switzerland in the dry regime.

### 3 Results and discussions

Scanning electron microscopy with energy dispersive X-ray spectroscopy (SEM/EDX) is the most widely-used of the surface analytical techniques. SEM images were performed using a Zeiss EVO 50 SEM having LaB6 cathode with Bruker EDX system. EDX measurements were carried out with a Bruker accessory fitted on the Zeiss Evo 50 scanning electron microscope. The take-off angle is 35° and the detector’s resolution is 133 eV.

![Mapping](image)

a) Ti Mg/Si
Figure 2 SEM micrographs of the Ti-Mg thin films

Scanning electron microscope (SEM) investigations revealed that the Ti-Mg thin films on each substrates were compact and uniform, while the average particle sizes of the nanoparticles composing the Ti-Mg thin films on different substrates are in range of ~4 nm corresponding with the calculated particles achieved by the Scherrer equation. The mean size \( D \) of the ordered (crystalline) domains, which may be smaller or equal to the grain size, was carried out by using Debye-Scherrer relation:

\[
D = \frac{K \lambda}{\beta \cos \theta}
\]

where \( K \) is the shape factor, \( \lambda \) is the wavelength, \( \beta \) is the line broadening at half the maximum intensity (FWHM) in radians, and \( \theta \) is the Bragg angle.

Usually the dimensionless shape factor has a typical value of about 0.9, but varies with the actual shape of the crystallite. Several factors can contribute to the width of a diffraction peak; besides crystallite size, the most important of these are usually inhomogeneous strain and instrumental effects. If we do not take into account these other contributions to the peak width, then the peak width would be determined solely by the crystallite size, in this case calculated as 3.2 nm.

More information about the morphology and structure of the Ti-Mg thin films have been provided by Transmission Electron Microscopy (TEM) performed on a Phillips CM 120 ST (acceleration voltage of 120 kV) TEM with a resolution point of 1.4 Å and a magnification of 1.2 million times. For TEM investigation the samples were prepared using a diamond knife to scratch the surface of the film, with alcohol as a dispersive medium and a 400 Cu grid covered by formvar film as a holder for the sample. [22]
Figure 4 (a) HRTEM image of Mg-Ti/Gl; (b) Grain size distribution

TEM images at different resolutions (200 nm and 500 nm) are shown in figure 3 and figure 4 and the grain size distribution using the Feret diameter estimate for the selected area in the image. The deposited thin films are nanostructured and the size of nanocrystalline structures according to Feret diameter is about 74 nm, 20 nm lower than the arithmetic mean of the determined values, which can be attributed to the small number of values used in the statistical analysis. The difference is within the range given by the standard deviation (± 26.9nm).

For each sample, diffraction analysis was performed, using phase analysis to compare the known phases of the material, namely the Cohen method with the modified Nelson-Riley function for electron diffraction.

Figures 4 and 5 shows the diffraction patterns obtained, respectively the radial distribution profile and the peaks obtained using the ELD for polycrystalline materials implemented in the CRISP2 application. To identify the phases, we compared the peaks obtained from the measurements with known Si [23] and Mg [24] and Ti [25] respectively, and their oxides: MgO [26], and TiO [27].

For Ti-Mg deposited on Si from the Debye-Scherrer analysis of the two profiles results a size of 1.7538 nm for the profile obtained on the amorphous film, respectively 5.8905 nm for the area leading to the formation of the polycrystalline diffraction pattern.

In Figure 5 and figure 6 are those patterns and related RDF. Profile analysis was made by means CRISP2 (ELD module) application. We use CRISP2 to extract and fit profile. The film is compound by nanoparticles very smoothly distributed, indicated by the presence of the well - defined rings by electron diffraction.
It can be seen that in the case of Mg the parameters are close to the values determined by other methods [Mg], instead of Ti, the parameters are very high, due to the small number of identification lines for this phase.

From a morphological point of view, the Ti-Mg/Gl coatings are a polycrystalline materials, the Debye-Scherrer analysis of the diffraction pattern showing a distribution of crystalline grains of approximately 5.63 nm.

Figure 7 Friction coefficient for Ti-Mg/OLC and Ti-Mg/Gl thin films

Tribological measurements for Ti-Mg deposited on OLC 45 substrate were performed using a ball-on-disc tribometer, with a normal force of 1 N, 2 N, 3 N and 5 N, respectively. In the case of Ti-Mg deposited on glass substrate the measurements were achieved with a normal force of 0.5 N, 1 N and 2 N, respectively. The stainless steel ball has a diameter of 6 mm, a dry sliding distance of 20 m, and a linear speed of 2cm/s. Figure 7 shows a comparative view of the friction coefficient for Ti-Mg films deposited on the OLC 45 and glass substrate at different loading forces. An increasing tendency of the friction coefficient with the increase of the applied force was noticed for Ti-Mg thin films.

4 Conclusions

Thermionic Vacuum Arc technology can be used successfully for Ti-Mg coatings deposition, providing superior qualities and high purity. The nanocomposites were investigated using Transmission Electron Microscopy (TEM) analyses provided with HR-TEM and SAED facilities. For Ti-Mg samples the amorphous phase, respectively hexagonal Mg and less probable Ti hexagonal could be identified. It can be said that there is an unequal percentage, the hexagonal Mg phase being predominant, and there is also the possibility of a relatively small percentage of cubic MgO. Selected area electron diffraction (SAED) technique provided the crystalline characteristics of the titanium in magnesium matrix. Characterization with Scanning Electron Microscopy (SEM) revealed that the particle size of the nanoparticles composing the Ti-Mg thin films on different substrates is in the nanometer scale and confirmed the calculated value of particle size from Debye Scherrer’s formula. Tribological measurements show an increasing tendency of the friction coefficient with the increase of the applied force, especially in the case of the film deposited on the glass.

The finding that the grain size distributions are different in Ti-Mg deposited on different substrates and depend on the growth conditions is important and must be taken into account in the search of the optimal composition to improve the coating properties of these materials for industrial applications

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References

14. Guangyu Zhao, Li Zhang, Yanning Niu, Kening Sun 2017 Electrochimica Acta 224 64–70
21. R. Vladoiu, A. Mandes, V. Dinca, G. Prodan, V. Ciupina 2016 Romanian Reports In Physics 68 1076-1084
22. V.S. Teodorescu, M-G. Blanchin 2009 Microsc. Microanal. 5 15
24. (WWW-MINCRYST, MAGNESIUM-2671) Swanson and Tatge 1951 * JC Fel. Reports, NBS
25. (WWW-MINCRYST, TITANIUM-4770); Wyckoff R.W.G. 1963 * Crystal Structures 1 9-11;
27. (WWW-MINCRYST, ANATASE-190), Wyckoff R.W.G. 1963 * Crystal Structures 1 253-254;